

# **SNx4ACT00 Quadruple 2-Input Positive-NAND Gates**

### 1 Features

- 4.5V to 5.5V  $V_{CC}$  operation
- Inputs accept voltages to 5.5V
- Max t<sub>pd</sub> of 8ns at 5V
- Inputs are TTL-voltage compatible

## 2 Description

The 'ACT00 devices contain four independent 2input NAND gates. Each gate performs the Boolean function of  $Y = \overline{A \cdot B}$  or  $Y = \overline{A} + \overline{B}$  in positive logic.

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE(2)	BODY SIZE(3)
	D (SOIC , 14)	8.65mm × 6mm	8.65mm × 3.9mm
	DB (SSOP, 14)	6.20mm × 7.8mm	6.20mm × 5.30mm
SNx4ACT00	N (PDIP, 14)	19.30mm × 9.4mm	19.30mm × 6.35mm
	NS (SOP, 14)	10.2mm × 7.8mm	10.30mm × 5.30mm
	PW (TSSOP,14)	5mm × 6.4mm	mm × 4.4mm

- (1) For more information, see Mechanical, Packaging, and Orderable Information.
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.



Logic Diagram, Each Gate (Positive Logic)



# **Table of Contents**

1 Features	1	7 Application and Implementation
2 Description		7.1 Power Supply Recommendations
3 Pin Configuration and Functions	3	7.2 Layout
4 Specifications	4	8 Device and Documentation Support
4.1 Absolute Maximum Ratings		8.1 Documentation Support (Analog)
4.2 Recommended Operating Conditions	4	8.2 Receiving Notification of Documentation Updates
4.3 Thermal Information		8.3 Support Resources
4.4 Electrical Characteristics	5	8.4 Trademarks
4.5 Switching Characteristics	5	8.5 Electrostatic Discharge Caution
4.6 Operating Characteristics		8.6 Glossary
5 Parameter Measurement Information	6	9 Revision History
6 Detailed Description	6	10 Mechanical, Packaging, and Orderable
6.1 Functional Block Diagram	6	Information
6.2 Device Functional Modes		



# 3 Pin Configuration and Functions

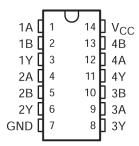
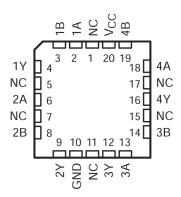


Figure 3-1. SN54ACT00 J or W Package; SN74ACT00 D, DB, N, NS, or PW Package (Top View)



NC - No internal connection

Figure 3-2. SN54ACT00 FK Package (Top View)

**Table 3-1. Pin Functions** 

P	PIN		PIN TYPE <sup>(1)</sup>		DESCRIPTION
NAME	NO.	ITPE	DESCRIPTION		
1A	1	I	Channel 1, Input A		
1B	2	I	Channel 1, Input B		
1Y	3	0	Channel 1, Output Y		
2A	4	I	Channel 2, Input A		
2B	5	I	Channel 2, Input B		
2Y	6	0	Channel 2, Output Y		
3A	9	0	Channel 3, Output Y		
3B	10	I	Channel 3, Input A		
3Y	8	I	Channel 3, Input B		
4A	12	0	Channel 4, Output Y		
4B	13	I	Channel 4, Input A		
4Y	11	I	Channel 4, Input B		
GND	7	G	Ground		
V <sub>CC</sub>	14	Р	Positive Supply		

(1) Signal Types: I = Input, O = Output, I/O = Input or Output, P = Power Supply, G = Ground.



## 4 Specifications

## 4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range	Supply voltage range			V
V <sub>I</sub> (2)	Input voltage range	Input voltage range		V <sub>CC</sub> + 0.5	V
V <sub>O</sub> (2)	Output voltage range		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	$(V_I < 0 \text{ or } V_I > V_{CC})$		±20	mA
I <sub>OK</sub>	Output clamp current	$(V_O < 0 \text{ or } V_O > V_{CC})$		±20	mA
Io	Continuous output current	(V <sub>O</sub> = 0 to V <sub>CC</sub> )		±50	mA
	Continuous current through V <sub>CC</sub> or GN	D		±200	mA
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 4.2 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

		SN54	SN54ACT00		SN74ACT00	
		MIN	MAX	MIN MAX		UNIT
V <sub>CC</sub>	Supply voltage	4.5	5.5	4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	2		2		V
$V_{IL}$	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
Vo	Output voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current		-24		-24	mA
I <sub>OL</sub>	Low-level output current		24		24	mA
Δt/Δν	Input transition rise or fall rate		8		8	ns/V
T <sub>A</sub>	Operating free-air temperature	-55	125	-40	85	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## 4.3 Thermal Information

THERMAL METRIC (1)							
		D (SOIC)	DB (SSOP)	N (PDIP	NS (SOP)	PW (TSSOP)	UNIT
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	119.9	96	80	76	145.7	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

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<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



### 4.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ONG	V	1	<sub>A</sub> = 25°C		SN54A	СТОО	SN74ACT00		UNIT
FARAIVIETER	1EST CONDITIO	JNS	V <sub>CC</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
	I - 50 uA		4.5 V	4.4	4.49		4.4		4.4		
	I <sub>OH</sub> = -50 μA		5.5 V	5.4	5.49		5.4		5.4		
\ <u>\</u>	L = 24 m A		4.5 V	3.86			3.7		3.76		V
V <sub>OH</sub>	I <sub>OH</sub> = -24 mA		5.5 V	4.86			4.7		4.76		V
	I <sub>OH</sub> = -50 mA <sup>(1)</sup>		5.5 V				3.85				
	I <sub>OH</sub> = -75 mA <sup>(1)</sup>		5.5 V						3.85		
	Ι <sub>ΟL</sub> = 50 μΑ		4.5 V		0.001	0.1		0.1		0.1	V
			5.5 V		0.001	0.1		0.1		0.1	
\ <u>\</u>	1 = 24 m A					0.36		0.5		0.44	
V <sub>OL</sub>	I <sub>OH</sub> = 24 mA		5.5 V			0.36		0.5		0.44	
	I <sub>OH</sub> = 50 mA <sup>(1)</sup>		5.5 V					1.65			
	I <sub>OH</sub> = 75 mA <sup>(1)</sup>		5.5 V							1.65	
II	V <sub>I</sub> = V <sub>CC</sub> or GND		5.5 V			±0.1		±1		±1	μA
Icc	V <sub>I</sub> = V <sub>CC</sub> or GND	I <sub>O</sub> = 0	5.5 V			2		40		20	μA
ΔI <sub>CC</sub> (2)	One input at 3.4 V, Ot at GND or V <sub>CC</sub>	her inputs	5.5 V		0.6			1.6		1.5	mA
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND		5 V		2.6						pF

<sup>(1)</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

## 4.5 Switching Characteristics

over recommended operating free-air temperature range,  $V_{CC}$  = 5 V  $\pm$  0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM	TO (OUTPUT)	Т	A= 25°C		SNx4A	CT00	SNx4A	СТ00	UNIT
PARAMETER	(INPUT)	10 (001701)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	ONIT
t <sub>PLH</sub>	A or B	V	1.5	5.5	9	1	9.5	1	9.5	no
t <sub>PHL</sub>	AUID	ľ	1.5	4	7	1	7	1	8	ns

## 4.6 Operating Characteristics

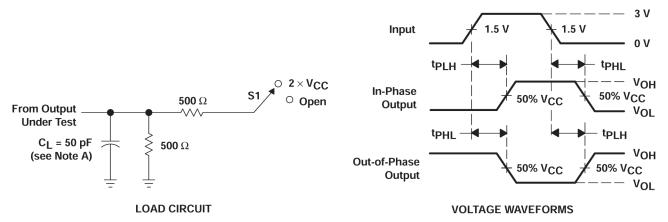
 $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$ 

	PARAMETER	TEST CO	TYP	UNIT	
$C_{pd}$	Power dissipation capacitance	C <sub>L</sub> = 50 pF	f = 1 MHz	40	pF

<sup>(2)</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or V<sub>CC</sub>.



## **5 Parameter Measurement Information**



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_0 = 50 \Omega$ ,  $t_r \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 5-1. Load Circuit and Voltage Waveforms

TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open

## **6 Detailed Description**

## 6.1 Functional Block Diagram



Figure 6-1. Logic Diagram, Each Gate (Positive Logic)

#### **6.2 Device Functional Modes**

Table 6-1. Function Table (Each Gate)

INF	PUTS	OUTPUT
Α	В	Y
Н	Н	L
L	X	Н
X	L	Н



## 7 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## 7.1 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in the following layout example.

### 7.2 Layout

## 7.2.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must never be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V<sub>CC</sub>, whichever makes more sense for the logic function or is more convenient.

## 7.2.2 Layout Example

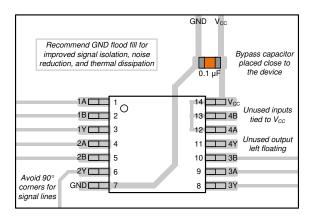


Figure 7-1. Example Layout for the SNx4ACT00

## 8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

## 8.1 Documentation Support (Analog)

#### 8.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 8-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54ACT00	Click here	Click here	Click here	Click here	Click here
SN74ACT00	Click here	Click here	Click here	Click here	Click here

## 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

## 8.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 8.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 8.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

### Changes from Revision D (October 2003) to Revision E (July 2024)

Page



# 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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## **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8769901M2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 8769901M2A SNJ54 ACT00FK	Samples
5962-8769901MCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769901MC A SNJ54ACT00J	Samples
5962-8769901MDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769901MD A SNJ54ACT00W	Samples
SN74ACT00D	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-40 to 85	ACT00	
SN74ACT00DBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AD00	Samples
SN74ACT00DR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ACT00	Samples
SN74ACT00N	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74ACT00N	Samples
SN74ACT00NE4	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74ACT00N	Samples
SN74ACT00NSR	ACTIVE	SOP	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ACT00	Samples
SN74ACT00PW	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-40 to 85	AD00	
SN74ACT00PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AD00	Samples
SN74ACT00PWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AD00	Samples
SNJ54ACT00FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 8769901M2A SNJ54 ACT00FK	Samples
SNJ54ACT00J	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769901MC A SNJ54ACT00J	Samples
SNJ54ACT00W	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769901MD A SNJ54ACT00W	Samples



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(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN54ACT00, SN74ACT00:

Catalog: SN74ACT00

Automotive: SN74ACT00-Q1, SN74ACT00-Q1

Military: SN54ACT00



## **PACKAGE OPTION ADDENDUM**

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## NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications



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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ACT00DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74ACT00DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74ACT00DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74ACT00NSR	SOP	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74ACT00PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74ACT00PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74ACT00PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74ACT00PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ACT00DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74ACT00DR	SOIC	D	14	2500	356.0	356.0	35.0
SN74ACT00DR	SOIC	D	14	2500	353.0	353.0	32.0
SN74ACT00NSR	SOP	NS	14	2000	356.0	356.0	35.0
SN74ACT00PWR	TSSOP	PW	14	2000	353.0	353.0	32.0
SN74ACT00PWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74ACT00PWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74ACT00PWRG4	TSSOP	PW	14	2000	353.0	353.0	32.0

# **PACKAGE MATERIALS INFORMATION**

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## **TUBE**



\*All dimensions are nominal

7 til dillicilololio die Homiliai								
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-8769901M2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-8769901MDA	W	CFP	14	25	506.98	26.16	6220	NA
SN74ACT00N	N	PDIP	14	25	506	13.97	11230	4.32
SN74ACT00N	N	PDIP	14	25	506	13.97	11230	4.32
SN74ACT00NE4	N	PDIP	14	25	506	13.97	11230	4.32
SN74ACT00NE4	N	PDIP	14	25	506	13.97	11230	4.32
SNJ54ACT00FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54ACT00W	W	CFP	14	25	506.98	26.16	6220	NA

# W (R-GDFP-F14)

# CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
   Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
   Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE INTEGRATED CIRCUIT



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



## **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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